

900V N-Channel MOSFET

Description

The MS9N90 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220 package is universally preferred for all commercial-industrial applications

Features

- R_{DS(on)} (Max 1.4 Ω)@V_{GS}=10V
- Gate Charge (Typical 47nC)
- · Improved dv/dt Capability, High Ruggedness
- · 100% Avalanche Tested
- Maximum Junction Temperature Range (150°C)
- · RoHS compliant package

Application

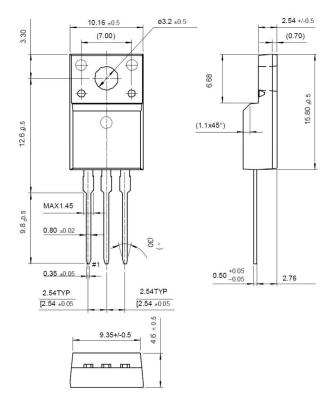
- Adapter
- · Switching Mode Power Supply

Packing & Order Information

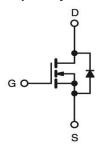
50/Tube; 1,000/Box



RoHS COMPLIANT



Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise specified)						
Symbol	Parameter	Value	Unit			
V_{DSS}	Drain-Source Voltage	900	V			
V _{GS}	Gate-Source Voltage	±30	V			
	Drain Current -Continuous (TC=25°C)	9	Α			
I _D	Drain Current -Continuous (TC=100°C)	6	Α			
I _{DM}	Drain Current -Pulsed	36	Α			
E _{AS}	Single Pulsed Avalanche Energy	900	mJ			
E _{AR}	Repetitive Avalanche Energy	28	mJ			
dV/dt	Peak Diode Recovery dV/dt	4.0	V/ns			
П	Power Dissipation (TC=25°C)	280	W			
P_{D}	- Derate above 25C	2.22	W/°C			
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C			



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Absolute Maximum Ratings (Tc=25°C unless otherwise specified)						
Symbol	Parameter	Value	Unit			
TL	Maximum lead temperature for soldering purposes,	300	°C			
	1/8" from case for 5 seconds	300	C			

[•] Drain current limited by maximum junction temperature

Thermal Resistance Characteristics							
Symbol	Parameter	Тур.	Max.	Units			
$R_{\theta JC}$	Junction-to-Case		0.75	°C/W			
$R_{\theta JA}$	Junction-to-Ambient		62.5	C/VV			

On Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V	
*R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V , I _D = 4.5 A		1.10	1.40	Ω	

Off Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	900			V	
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		1.05		V/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 900 V , V _{GS} = 0 V V _{DS} = 720 V , V _C = 125°C			10 100	μA	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{DS} = 30 V, V _{DS} = 0 V			100	μA	
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{DS} = -30 V, V _{DS} = 0 V			-100	nA	

Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
C _{ISS}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{MHz}$		2200		pF	
Coss	Output Capacitance			180		pF	
C _{RSS}	Reverse Transfer Capacitance	1 – 1.01/11/12		15		pF	



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Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
$t_{d(on)}$	Turn-On Time	$V_{DS} = 450 \text{ V}, I_{D} = 9 \text{ A},$ $R_{G} = 25 \Omega$		60		ns	
t _r	Turn-On Time			130		ns	
t _{d(off)}	Turn-Off Delay Time			110		ns	
tf	Turn-Off Fall Time			80		ns	
Qg	Total Gate Charge	$V_{DS} = 720 \text{ V}, I_{D} = 10 \text{ A},$ $V_{GS} = 9 \text{ V}$		47		nC	
Q_{gs}	Gate-Source Charge			15		nC	
Q_{gd}	Gate-Drain Charge			20		nC	

Source-Drain Diode Maximum Ratings and Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
Is	Continuous Source-Drain Diode Forwa	tinuous Source-Drain Diode Forward Current 9.0					
I _{SM}	ISM Pulsed Source-Drain Diode Forward Current				35	- A	
V _{SD}	Source-Drain Diode Forward Voltage	I _S = 9 A , V _{GS} = 0 V			1.4	V	
t _{rr}	Reverse Recovery Time	I _S = 9 A , V _{GS} = 0 V		550		ns	
Q _{rr}	Reverse Recovery Charge	diF/dt=100A/µs		6.5		μC	

Notes:

- 1. Repeativity rating: pulse width limited by junction temperature
- 2. L = 21mH, I_{AS} =9.0A, V_{DD} = 50V, R_{G} = 25 Ω , Starting TJ = 25 $^{\circ}C$
- 3. $I_{SD} \le 9.0A$, di/dt $\le 200A/us$, VDD $\le BVDSS$, Starting TJ = 25°C
- 4. Pulse Test : Pulse Width ≤ 300us, Duty Cycle ≤ 2%
- 5. Essentially independent of operating temperature.



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